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FIG. 1 (PRIOR ART)

IC CHIP—		100
		-104
	. 102	
	BUFFER CIRCUIT	

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 $FIG.~~\mathcal{Z}$ (PRIOR ART)

					100′		
106 —			102		104		

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FIG. 3 (PRIOR ART)



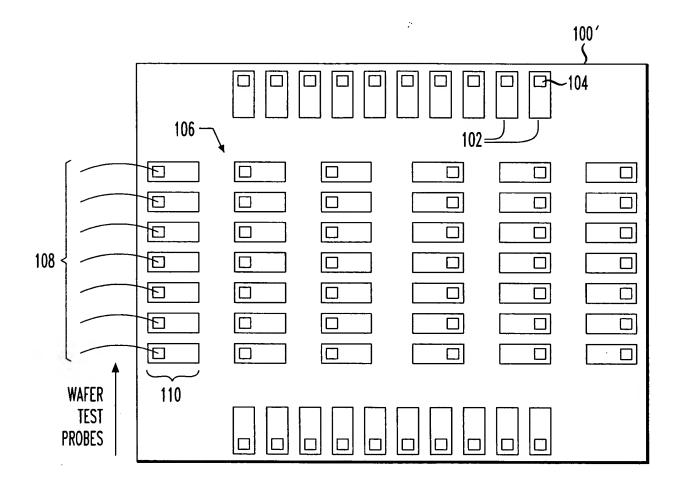
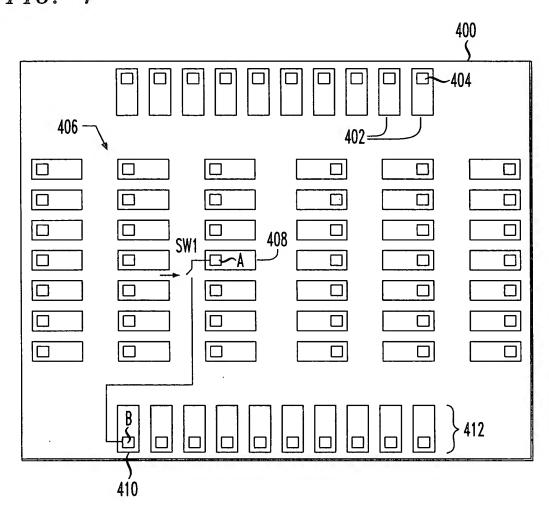




FIG. 4

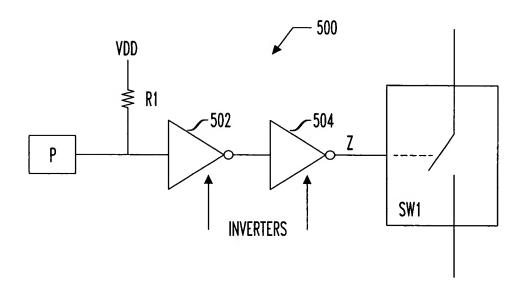


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FIG. 5



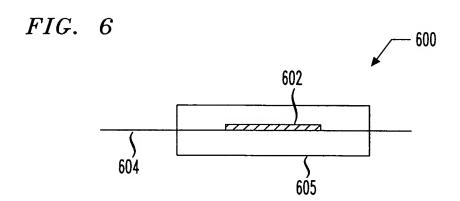




FIG. 7

